Customer No.: 31561 Application No.: 10/710,419

Docket No.: 11579-US-PA

## **AMENDMENTS**

Please amend the application as indicated hereafter.

## To the Claims:

1. (original) A wafer structure, comprising:

a wafer having a plurality of bonding pads, wherein the bonding pads are disposed on an active surface of the wafer;

a first passivation layer covering the active surface of the wafer, wherein the bonding pads are exposed by the first passivation layer;

an under ball metallurgy (UBM) layer disposed on each of the bonding pads, wherein the UBM layer comprises a first metallic layer and a second metallic layer disposed on the first metallic layer, the first metallic layer covering a portion of the first passivation layer;

a second passivation layer disposed on the first passivation layer, wherein the second passivation layer covers a peripheral portion of the first metallic layer, without covering the second metallic layer; and

- a plurality of bumps, disposed on the UBM layer.
- 2. (original) The structure of claim 1, wherein the UBM layer comprises:
- an adhesion layer, disposed on the bonding pad;
- a barrier layer disposed on the adhesion layer;
- a wetting layer disposed between the barrier layer and the bump.
- 3. (original) The structure of claim 2, wherein the adhesion layer is a single layer

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or comprises a plurality of layers.

- 4. (original) The structure of claim 2, wherein the barrier layer is a single layer or comprises a plurality of layers.
- 5. (original) The structure of claim 2, wherein the wetting layer is a single layer or comprises a plurality of layers.
- 6. (original) The structure of claim 2, wherein the first metallic layer includes the adhesion layer and the second metallic layer includes the barrier layer and the wetting layer.
- 7. (original) The structure of claim 2, wherein the first metallic layer includes the adhesion layer and the barrier layer and the second metallic layer includes the wetting layer.
- 8. (original) The structure of claim 2, wherein a material of the adhesion layer is titanium or aluminum.
- 9. (original) The structure of claim 2, wherein a material of the barrier layer is selected from the group consisting of nickel-vanadium alloy, titanium nitride, tantalum nitride and nickel.
- 10. (original) The structure of claim 2, wherein a material of the wetting layer includes copper.
- 11. (original) The structure of claim 2, wherein a material of the second passivation layer is benzocyclobutene (BCB) or polyimide (PI).
- 12. (original) The structure of claim 2, wherein a material of the bumps includes tin/lead alloy.

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13. (original) The structure of claim 2, wherein the bumps are in globular shapes or pillar shapes.

Claims 14-22 (cancelled)